

**Notice of References Cited**

Application/Control No.

10/815,451

Applicant(s)/Patent Under  
Reexamination  
COATS, ELON RAY

Examiner

Devona E. Faulk

Art Unit

2615

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	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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